

RF Power LDMOS Transistor

N-Channel Enhancement-Mode Lateral MOSFET

This high ruggedness device is designed for use in high VSWR military, aerospace and defense, radar and radio communications applications. It is an unmatched input and output design allowing wide frequency range utilization, between 1.8 and 600 MHz.

Typical Performance: $V_{DD} = 50 \text{ Vdc}$

| Frequency (MHz) | Signal Type | P_{out} (W) | G_{ps} (dB) | η_D (%) |
|-----------------|--|---------------|---------------|--------------|
| 87.5–108 (1,3) | CW | 361 | 23.8 | 80.1 |
| 230 (2) | CW | 300 | 25.0 | 70.0 |
| 230 (2) | Pulse (100 μsec , 20% Duty Cycle) | 300 Peak | 27.0 | 71.0 |

Load Mismatch/Ruggedness

| Frequency (MHz) | Signal Type | VSWR | P_{in} (W) | Test Voltage | Result |
|-----------------|--|----------------------------|----------------------------|--------------|-----------------------|
| 98 (1) | CW | > 65:1 at all Phase Angles | 3 (3 dB Overdrive) | 50 | No Device Degradation |
| 230 (2) | Pulse (100 μsec , 20% Duty Cycle) | | 1.16 Peak (3 dB Overdrive) | | |

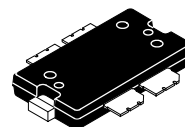
1. Measured in 87.5–108 MHz broadband reference circuit.
2. Measured in 230 MHz narrowband test circuit.
3. The values shown are the minimum measured performance numbers across the indicated frequency range.

Features

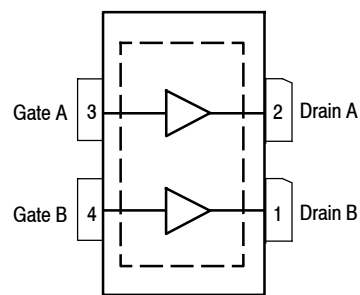
- Wide Operating Frequency Range
- Extreme Ruggedness
- Unmatched Input and Output Allowing Wide Frequency Range Utilization
- Integrated Stability Enhancements
- Low Thermal Resistance
- Integrated ESD Protection Circuitry
- In Tape and Reel. R1 Suffix = 500 Units, 44 mm Tape Width, 13-inch Reel.

MMRF1316NR1

**1.8–600 MHz, 300 W CW, 50 V
 WIDEBAND
 RF POWER LDMOS TRANSISTOR**



**TO-270WB-4
 PLASTIC**



(Top View)

Note: Exposed backside of the package is the source terminal for the transistors.

Figure 1. Pin Connections

Table 1. Maximum Ratings

| Rating | Symbol | Value | Unit |
|--|-----------|-------------|-----------|
| Drain-Source Voltage | V_{DSS} | -0.5, +133 | Vdc |
| Gate-Source Voltage | V_{GS} | -6.0, +10 | Vdc |
| Storage Temperature Range | T_{stg} | -65 to +150 | °C |
| Case Operating Temperature Range | T_C | -40 to +150 | °C |
| Operating Junction Temperature Range (1,2) | T_J | -40 to +225 | °C |
| Total Device Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C | P_D | 909 4.55 | W W/°C |

Table 2. Thermal Characteristics

| Characteristic | Symbol | Value (2,3) | Unit |
|--|-----------------|-------------|------|
| Thermal Resistance, Junction to Case CW: Case Temperature 81°C, 305 W CW, 50 Vdc, $I_{DQ(A+B)} = 100$ mA, 230 MHz | $R_{\theta JC}$ | 0.22 | °C/W |
| Thermal Impedance, Junction to Case Pulse: Case Temperature 59°C, 300 W Peak, 100 μsec Pulse Width, 20% Duty Cycle, 50 Vdc, $I_{DQ(A+B)} = 100$ mA, 230 MHz | $Z_{\theta JC}$ | 0.034 | °C/W |

Table 3. ESD Protection Characteristics

| Test Methodology | Class |
|---------------------------------------|-------------------|
| Human Body Model (per JESD22-A114) | 2, passes 2500 V |
| Machine Model (per EIA/JESD22-A115) | A, passes 150 V |
| Charge Device Model (per JESD22-C101) | IV, passes 2000 V |

Table 4. Moisture Sensitivity Level

| Test Methodology | Rating | Package Peak Temperature | Unit |
|--------------------------------------|--------|--------------------------|------|
| Per JESD22-A113, IPC/JEDEC J-STD-020 | 3 | 260 | °C |

Table 5. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

| Characteristic | Symbol | Min | Typ | Max | Unit |
|----------------|--------|-----|-----|-----|------|
|----------------|--------|-----|-----|-----|------|

Off Characteristics (4)

| | | | | | |
|--|---------------|-----|-----|----|-----------------|
| Gate-Source Leakage Current ($V_{GS} = 5$ Vdc, $V_{DS} = 0$ Vdc) | I_{GSS} | — | — | 1 | μAdc |
| Drain-Source Breakdown Voltage ($V_{GS} = 0$ Vdc, $I_D = 50$ mA) | $V_{(BR)DSS}$ | 133 | 140 | — | Vdc |
| Zero Gate Voltage Drain Leakage Current ($V_{DS} = 50$ Vdc, $V_{GS} = 0$ Vdc) | I_{DSS} | — | — | 5 | μAdc |
| Zero Gate Voltage Drain Leakage Current ($V_{DS} = 100$ Vdc, $V_{GS} = 0$ Vdc) | I_{DSS} | — | — | 10 | μAdc |

On Characteristics

| | | | | | |
|---|--------------|-----|------|-----|-----|
| Gate Threshold Voltage ($V_{DS} = 10$ Vdc, $I_D = 960$ μAdc) | $V_{GS(th)}$ | 1.8 | 2.3 | 2.8 | Vdc |
| Gate Quiescent Voltage ($V_{DD} = 50$ Vdc, $I_D = 100$ mAdc, Measured in Functional Test) | $V_{GS(Q)}$ | 2.2 | 2.7 | 3.2 | Vdc |
| Drain-Source On-Voltage ($V_{GS} = 10$ Vdc, $I_D = 2$ Adc) | $V_{DS(on)}$ | — | 0.26 | — | Vdc |

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.
4. Each side of device measured separately.

(continued)

Table 5. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted) (continued)

| Characteristic | Symbol | Min | Typ | Max | Unit |
|---|-----------|-----|-----|-----|------|
| Dynamic Characteristics (1) | | | | | |
| Reverse Transfer Capacitance ($V_{DS} = 50\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$) | C_{rss} | — | 1.4 | — | pF |
| Output Capacitance ($V_{DS} = 50\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz, $V_{GS} = 0\text{ Vdc}$) | C_{oss} | — | 63 | — | pF |
| Input Capacitance ($V_{DS} = 50\text{ Vdc}$, $V_{GS} = 0\text{ Vdc} \pm 30\text{ mV(rms)ac}$ @ 1 MHz) | C_{iss} | — | 168 | — | pF |

Functional Tests (2) (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 50\text{ Vdc}$, $I_{DQ(A+B)} = 100\text{ mA}$, $P_{out} = 300\text{ W Peak}$ (60 W Avg.), $f = 230\text{ MHz}$, 100 μsec Pulse Width, 20% Duty Cycle

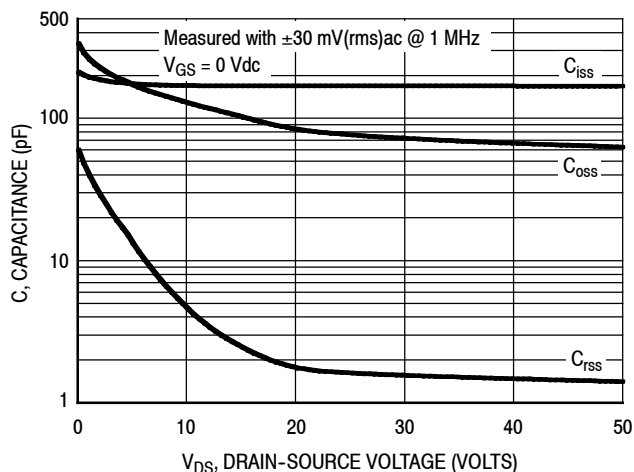
| | | | | | |
|-------------------|----------|------|------|------|----|
| Power Gain | G_{ps} | 26.0 | 27.0 | 28.5 | dB |
| Drain Efficiency | η_D | 69.0 | 71.0 | — | % |
| Input Return Loss | IRL | — | -20 | -9 | dB |

Table 6. Load Mismatch/Ruggedness (In Freescale Test Fixture, 50 ohm system) $I_{DQ(A+B)} = 100\text{ mA}$

| Frequency (MHz) | Signal Type | VSWR | P_{in} (W) | Test Voltage, V_{DD} | Result |
|-----------------|---|----------------------------|-------------------------------|------------------------|-----------------------|
| 230 | Pulse (100 μsec , 20% Duty Cycle) | > 65:1 at all Phase Angles | 1.16 Peak (3 dB Overdrive) | 50 | No Device Degradation |

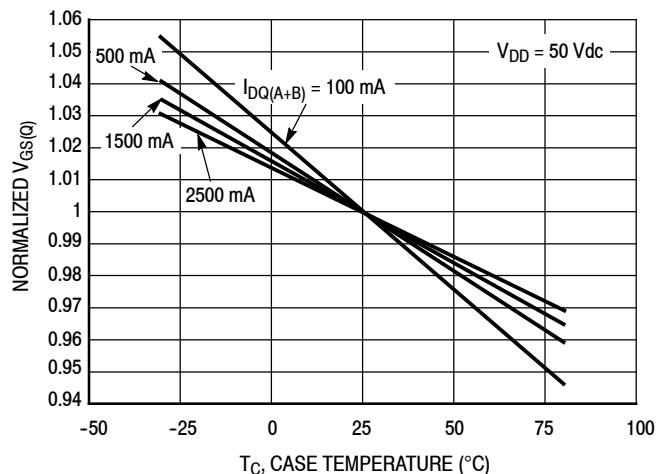
- Each side of device measured separately.
- Measurements made with device in straight lead configuration before any lead forming operation is applied. Lead forming is used for gull wing (GN) parts.

TYPICAL CHARACTERISTICS



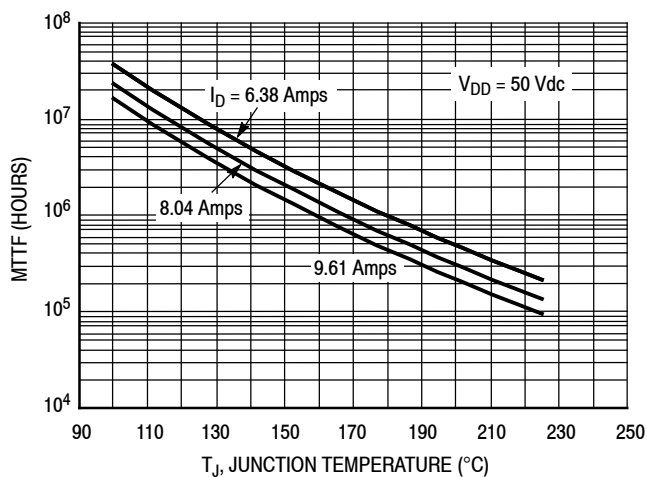
Note: Each side of device measured separately.

Figure 2. Capacitance versus Drain-Source Voltage



| I_{DQ} (mA) | Slope (mV/°C) |
|---------------|---------------|
| 100 | -2.651 |
| 500 | -2.158 |
| 1500 | -1.977 |
| 2500 | -1.787 |

Figure 3. Normalized V_{GS} versus Quiescent Current and Case Temperature



Note: MTTF value represents the total cumulative operating time under indicated test conditions.

MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.

Figure 4. MTTF versus Junction Temperature - CW

230 MHz NARROWBAND PRODUCTION TEST FIXTURE

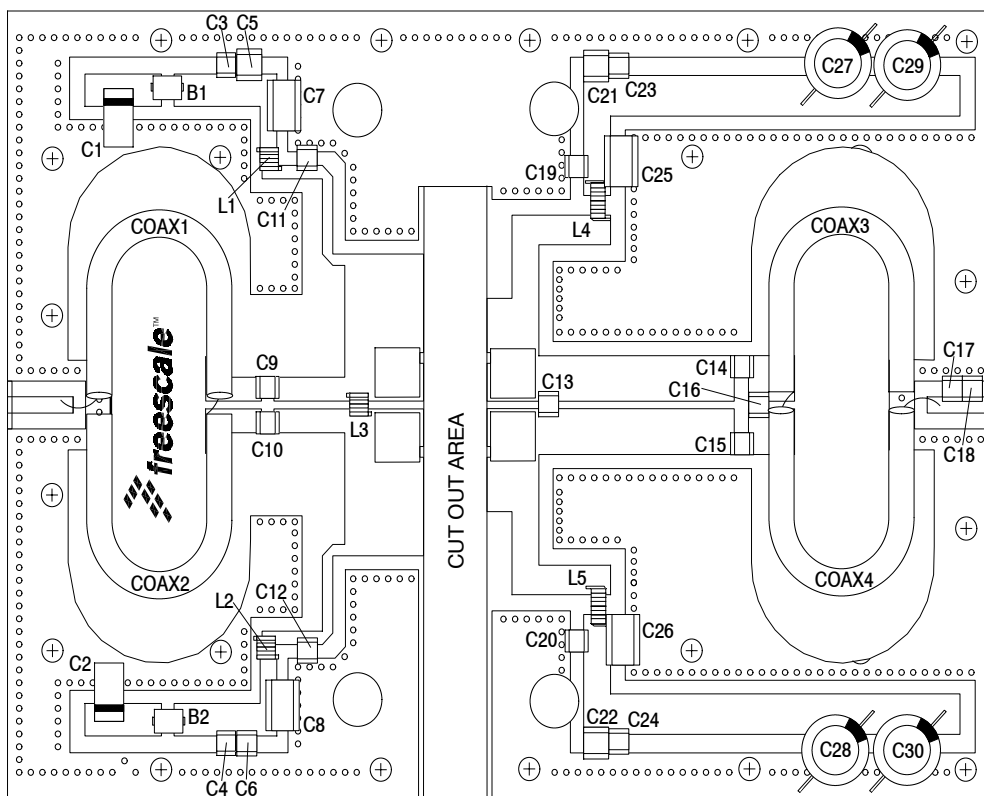


Figure 5. MMRF1316NR1 Narrowband Test Circuit Component Layout — 230 MHz

230 MHz NARROWBAND PRODUCTION TEST FIXTURE

Table 7. MMRF1316NR1 Narrowband Test Circuit Component Designations and Values — 230 MHz

| Part | Description | Part Number | Manufacturer |
|--------------------|---|----------------------|--------------|
| B1, B2 | Small Ferrite Beads, Surface Mount | 2743019447 | Fair-Rite |
| C1, C2 | 22 μ F, 35 V Tantalum Capacitors | T491X226K035AT | Kemet |
| C3, C4 | 0.1 μ F Chip Capacitors | CDR33BX104AKWS | AVX |
| C5, C6 | 220 nF Chip Capacitors | C1812C224K5RACTU | Kemet |
| C7, C8 | 2.2 μ F Chip Capacitors | C1825C225J5RACTU | Kemet |
| C9, C10, C11, C12 | 1000 pF Chip Capacitors | ATC100B102JT50XT | ATC |
| C13 | 75 pF Chip Capacitor | ATC100B750JT500XT | ATC |
| C14, C15 | 680 pF Chip Capacitors | ATC100B681JT200XT | ATC |
| C16 | 82 pF Chip Capacitor | ATC100B820JT500XT | ATC |
| C17 | 8.2 pF Chip Capacitor | ATC100B8R2CT500XT | ATC |
| C18 | 11 pF Chip Capacitor | ATC100B110JT500XT | ATC |
| C19, C20 | 240 pF Chip Capacitors | ATC100B241JT200XT | ATC |
| C21, C22 | 0.10 μ F Chip Capacitors | C1812F104K1RACTU | Kemet |
| C23, C24 | 0.1 μ F Chip Capacitors | CDR33BX104AKWS | AVX |
| C25, C26 | 2.2 μ F Chip Capacitors | 2225X7R225KJT3AB | ATC |
| C27, C28, C29, C30 | 470 μ F, 63 V Electrolytic Capacitors | MCGPR63V477M13X26-RH | Multicomp |
| Coax1, 2, 3, 4 | 25 Ω Semi Rigid Coax, 2.4" | UT-141C-25 | Micro-Coax |
| L1, L2 | 12 nH Inductors, 3 Turns | GA3094-ALC | Coilcraft |
| L3 | 22 nH Inductor | 1812SMS-22NJLC | Coilcraft |
| L4, L5 | 17.5 nH Inductors, 4 Turns | GA3095-ALC | Coilcraft |
| PCB | Arlon AD255A 0.030", $\epsilon_r = 2.55$ | D49840 | MTL |

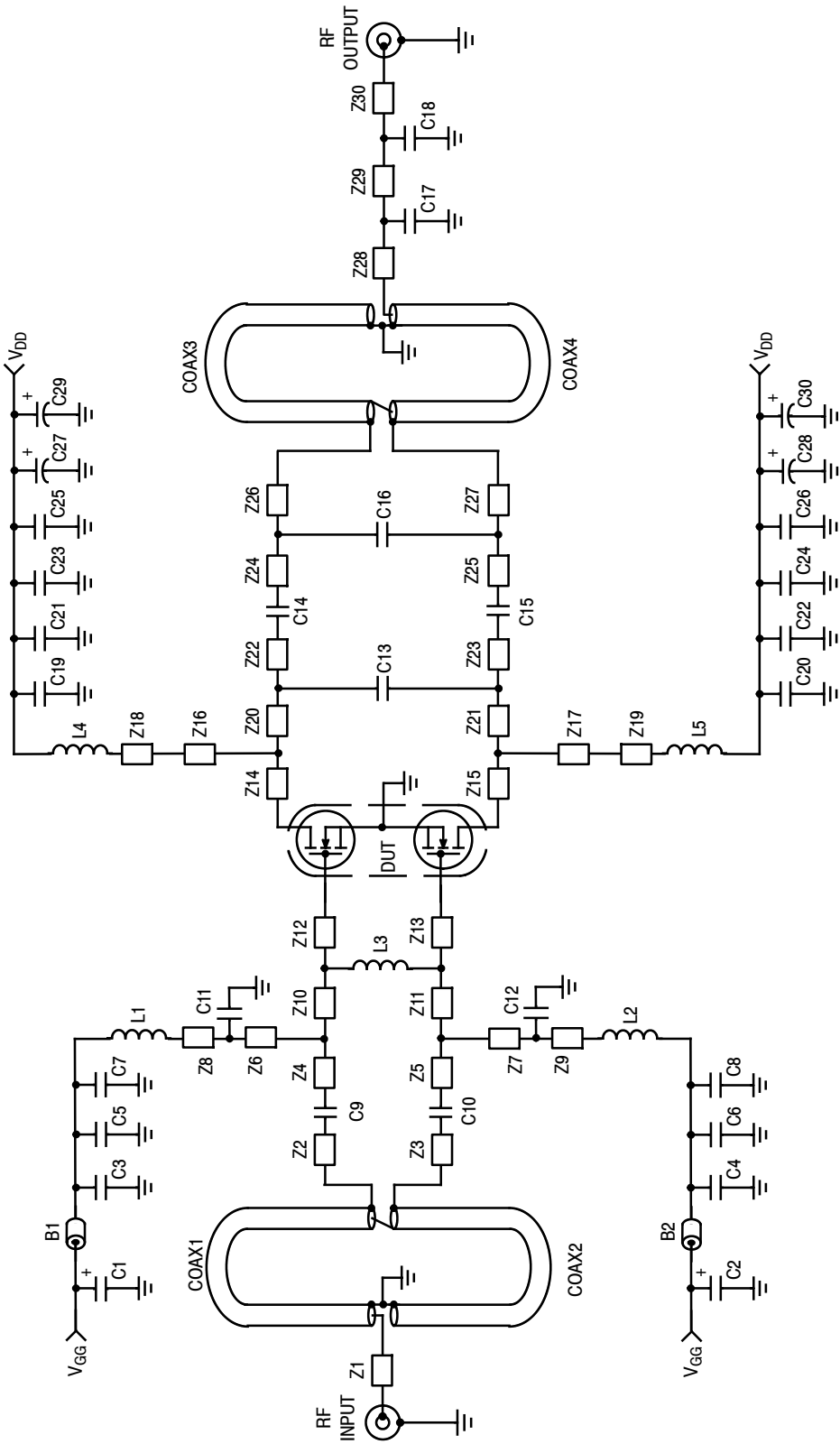


Figure 6. MMRF1316NR1 Narrowband Test Circuit Schematic — 230 MHz

Table 8. MMRF1316NR1 Narrowband Test Circuit Microstrips — 230 MHz

| Microstrip | Description | Microstrip | Description |
|------------|----------------------------|------------|----------------------------|
| Z1 | 0.366" x 0.082" Microstrip | Z12, Z13 | 0.361" x 0.746" Microstrip |
| Z2, Z3 | 0.169" x 0.120" Microstrip | Z14, Z15 | 0.289" x 0.522" Microstrip |
| Z4, Z5 | 0.432" x 0.120" Microstrip | Z16, Z17 | 0.347" x 0.150" Microstrip |
| Z6*, Z7* | 0.655" x 0.058" Microstrip | Z18, Z19 | 0.329" x 0.150" Microstrip |
| Z8, Z9 | 0.252" x 0.068" Microstrip | Z20, Z21 | 0.060" x 0.230" Microstrip |
| Z10, Z11 | 0.078" x 0.746" Microstrip | Z22, Z23 | 1.040" x 0.230" Microstrip |
| | | Z24, Z25 | 0.057" x 0.230" Microstrip |
| | | Z26, Z27 | 0.199" x 0.230" Microstrip |
| | | Z28 | 0.155" x 0.082" Microstrip |
| | | Z29 | 0.110" x 0.082" Microstrip |
| | | Z30 | 0.100" x 0.082" Microstrip |

* Line length include microstrip bends

TYPICAL CHARACTERISTICS — 230 MHz

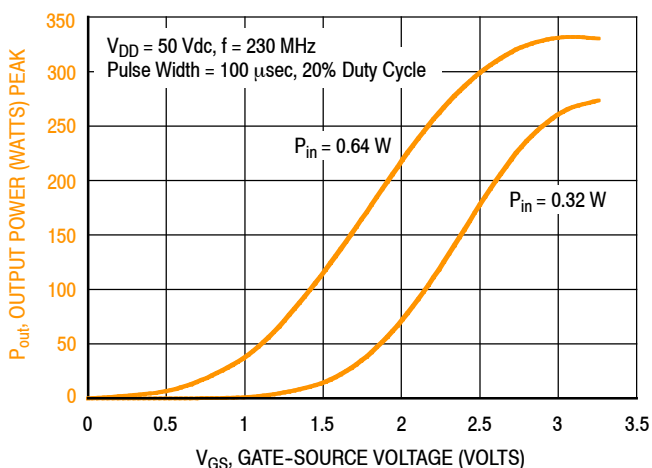
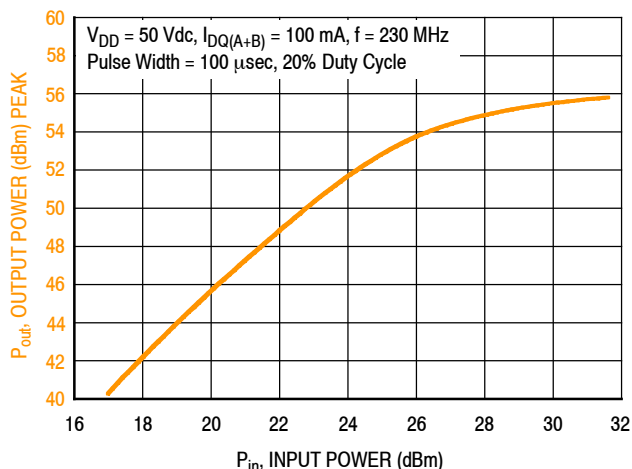


Figure 7. Output Power versus Gate-Source Voltage at a Constant Input Power



| f (MHz) | P1dB (W) | P3dB (W) |
|---------|----------|----------|
| 230 | 313 | 370 |

Figure 8. Output Power versus Input Power

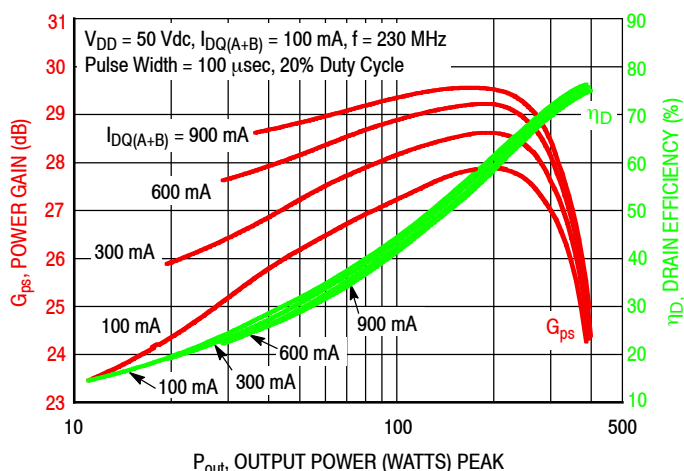


Figure 9. Power Gain and Drain Efficiency versus Output Power and Quiescent Current

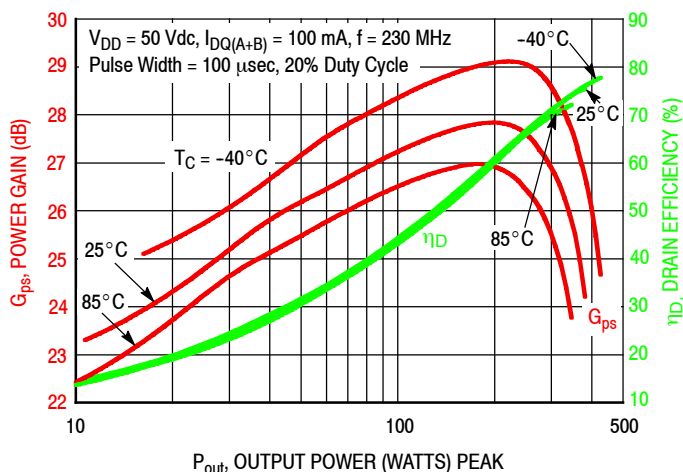


Figure 10. Power Gain and Drain Efficiency versus CW Output Power

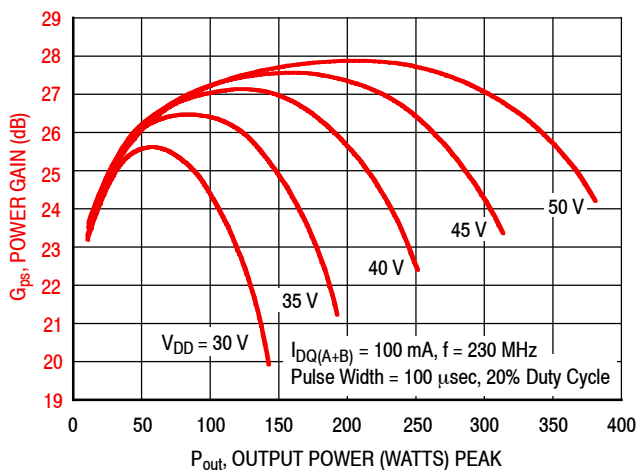


Figure 11. Power Gain versus Output Power and Drain-Source Voltage

230 MHz NARROWBAND PRODUCTION TEST FIXTURE

$V_{DD} = 50 \text{ Vdc}$, $I_{DQ(A+B)} = 100 \text{ mA}$, $P_{out} = 300 \text{ W Peak}$

| f MHz | Z_{source} Ω | Z_{load} Ω |
|----------|--------------------------|------------------------|
| 230 | $1.50 - j10.70$ | $8.30 + j6.90$ |

Z_{source} = Test circuit impedance as measured from gate to gate, balanced configuration.

Z_{load} = Test circuit impedance as measured from drain to drain, balanced configuration.

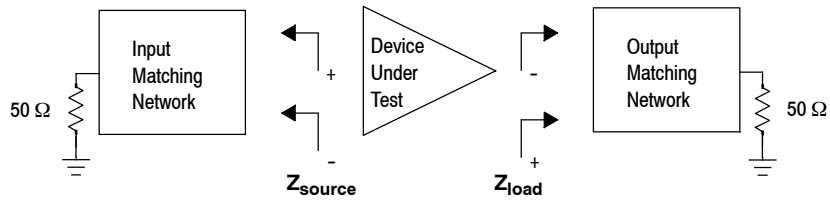


Figure 12. Narrowband Series Equivalent Source and Load Impedance — 230 MHz

87.5–108 MHz BROADBAND REFERENCE CIRCUIT

Table 9. 87.5–108 MHz Broadband Performance (In Freescale Reference Circuit, 50 ohm system)

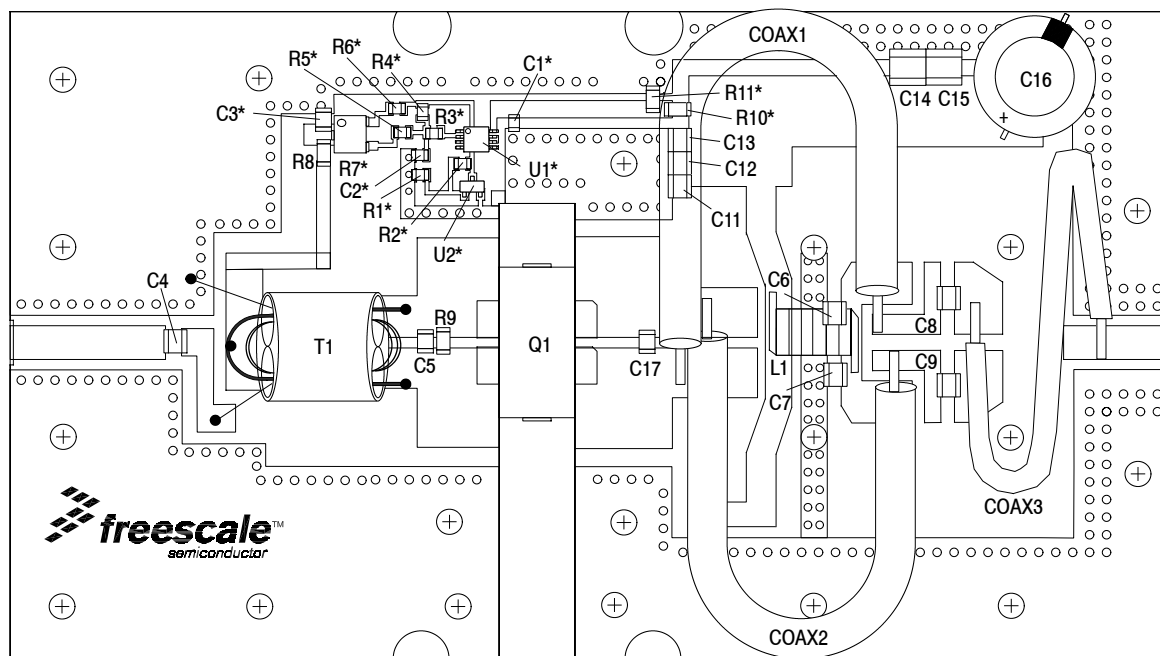
$V_{DD} = 50 \text{ Vdc}$, $I_{DQ(A+B)} = 100 \text{ mA}$, $P_{in} = 1.5 \text{ W}$, CW

| Frequency (MHz) | G_{ps} (dB) | η_D (%) | P_{out} (W) |
|-----------------|---------------|--------------|---------------|
| 87.5 | 24.4 | 80.1 | 415 |
| 98 | 24.3 | 81.8 | 404 |
| 108 | 23.8 | 80.5 | 361 |

Table 10. Load Mismatch/Ruggedness (In Freescale Reference Circuit, 50 ohm system) $I_{DQ(A+B)} = 100 \text{ mA}$

| Frequency (MHz) | Signal Type | VSWR | P_{in} (W) | Test Voltage, V_{DD} | Result |
|-----------------|-------------|-------------------------------|-----------------------|------------------------|-----------------------|
| 98 | CW | > 65:1 at all Phase Angles | 3 (3 dB Overdrive) | 50 | No Device Degradation |

87.5–108 MHz BROADBAND REFERENCE CIRCUIT



Note: Component number C10 is not used.

*Bias Regulator and Temperature Compensation. Refer to AN1643, *RF LDMOS Power Modules for GSM Base Station Application: Optimum Biasing Circuit*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes – AN1643.

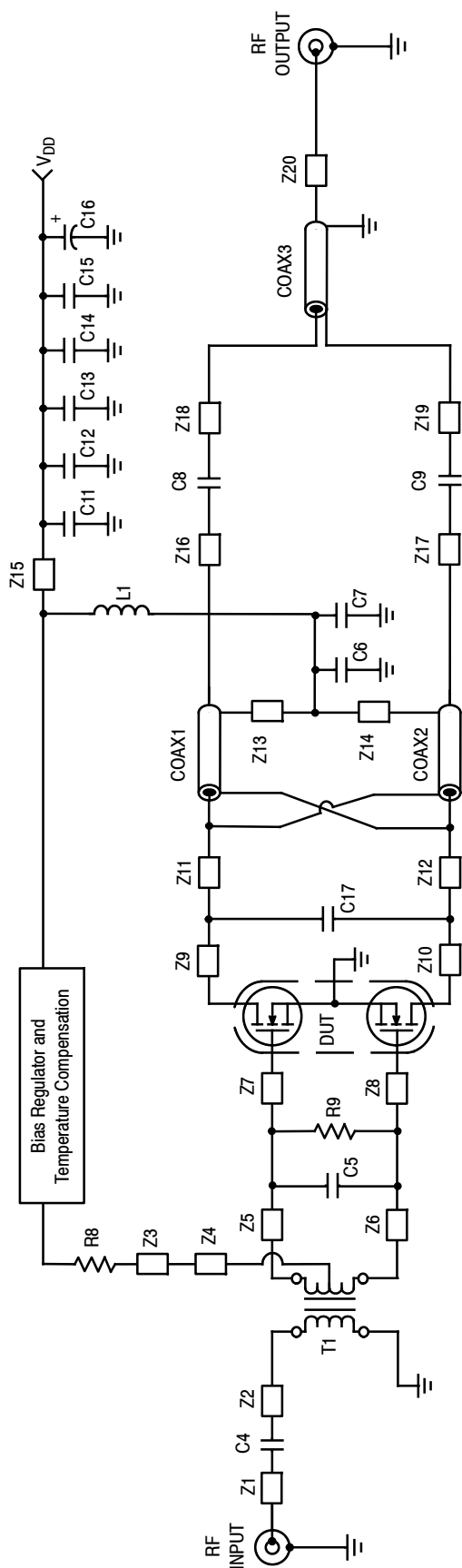
Figure 13. MMRF1316NR1 Broadband Reference Circuit Component Layout — 87.5–108 MHz

87.5–108 MHz BROADBAND REFERENCE CIRCUIT

Table 11. MMRF1316NR1 Broadband Reference Circuit Component Designations and Values — 87.5–108 MHz

| Part | Description | Part Number | Manufacturer |
|------------|---|---------------------|------------------|
| C1, C2 | 1 μ F Chip Capacitors | GRM31CR72A105KA01L | Murata |
| C3 | 10 nF Chip Capacitor | ATC200B103KT50XT | ATC |
| C4 | 150 pF Chip Capacitor | ATC100B151JT300XT | ATC |
| C5 | 20 pF Chip Capacitor | ATC100B200JT500XT | ATC |
| C6, C8, C9 | 1000 pF Chip Capacitors | ATC200B102KT50XT | ATC |
| C7 | 560 pF Chip Capacitor | ATC100B561KT50XT | ATC |
| C11 | 10 nF Chip Capacitor | GCJ216R72A103KA01D | Murata |
| C12 | 47 nF Chip Capacitor | GCJ21BR72A473KA01L | Murata |
| C13 | 470 nF Chip Capacitor | GRM31MR72A474KA01L | Murata |
| C14, C15 | 10 μ F Chip Capacitors | C5750X7S2A106M230KB | TDK |
| C16 | 470 μ F, 63 V Electrolytic Capacitor | MCGPR63V477M13X26 | Multicomp |
| C17 | 20 pF Chip Capacitor | ATC100B200JT500XT | ATC |
| Coax1, 2 | 35 Ω Flex Cable, 4.72" | HSF-141 | Hongsen Cable |
| Coax3 | 50 Ω Flex Cable, 6.3" | SM141 | Huber Suhner |
| L1 | 5 Turns, #16 AWG ID = 0.315"/8 mm Inductor, Hand Wound | Copper Wire | |
| Q1 | RF Power LDMOS Transistor | MMRF1316NR1 | Freescale |
| R1 | 2.2 k Ω , 1/8 W Chip Resistor | CRCW08052K20FKEA | Vishay |
| R2 | 390 Ω , 1/8 W Chip Resistor | CRCW0805390RFKEA | Vishay |
| R3 | 10 Ω , 1/8 W Chip Resistor | CRCW080510R0FKEA | Vishay |
| R4 | 1.0 k Ω , 1/8 W Chip Resistor | CRCW08051K00FKEA | Vishay |
| R5 | 2.7 k Ω , 1/8 W Chip Resistor | CRCW08052K70FKEA | Vishay |
| R6 | 200 Ω , 1/8 W Chip Resistor | CRCW0805200RFKEA | Vishay |
| R7 | 5.0 k Ω Multi-turn Cermet Trimmer Potentiometer | 3224W-1-502E | Bourns |
| R8 | 10 Ω , 1/4 W Chip Resistor | CRCW120610R0FKEA | Vishay |
| R9 | 240 Ω , 1/4 W Chip Resistor | CRCW1206240RFKEA | Vishay |
| R10 | 4.7 k Ω , 1/2 W Chip Resistor | CRCW12104K70FKEA | Vishay |
| R11 | 5.1 k Ω , 1/2 W Chip Resistor | CRCW12105K10FKEA | Vishay |
| T1 | 61 Material Binocular Core Ferrite (9:1) with 24 AWG 1 Turn Primary, 24 AWG 3 Turns Secondary, Hand Wound | 2861000202 | Fair-Rite |
| U1 | Voltage Regulator 5 V, Micro8 | LP2951ACDMR2G | ON Semiconductor |
| U2 | NPN Bipolar Transistor | BC847ALT1G | ON Semiconductor |
| PCB | Rogers RO4350B, 0.030", $\epsilon_r = 3.66$ | D59349 | MTL |

Note: Component number C10 is not used.



Note: Component number C10 is not used.

Figure 14. MMRF1316NR1 Broadband Reference Circuit Schematic — 87.5–108 MHz

Table 12. MMRF1316NR1 Broadband Reference Circuit Microstrips — 87.5–108 MHz

| Microstrip | Description | Microstrip | Description |
|------------|----------------------------|------------|----------------------------|
| Z1 | 0.430" x 0.150" Microstrip | Z11, Z12 | 0.400" x 0.240" Microstrip |
| Z2* | 0.320" x 0.080" Microstrip | Z13, Z14 | 0.170" x 0.210" Microstrip |
| Z3* | 0.680" x 0.080" Microstrip | Z15 | 0.680" x 0.140" Microstrip |
| Z4 | 0.310" x 0.170" Microstrip | Z16*, Z17* | 0.200" x 0.100" Microstrip |
| Z5, Z6 | 0.195" x 0.240" Microstrip | Z18, Z19 | 0.230" x 0.300" Microstrip |
| Z7, Z8 | 0.380" x 0.630" Microstrip | Z20 | 0.190" x 0.170" Microstrip |
| Z9, Z10 | 0.380" x 0.630" Microstrip | | |

* Line length includes microstrip bends

**TYPICAL CHARACTERISTICS — 87.5–108 MHz
BROADBAND REFERENCE CIRCUIT**

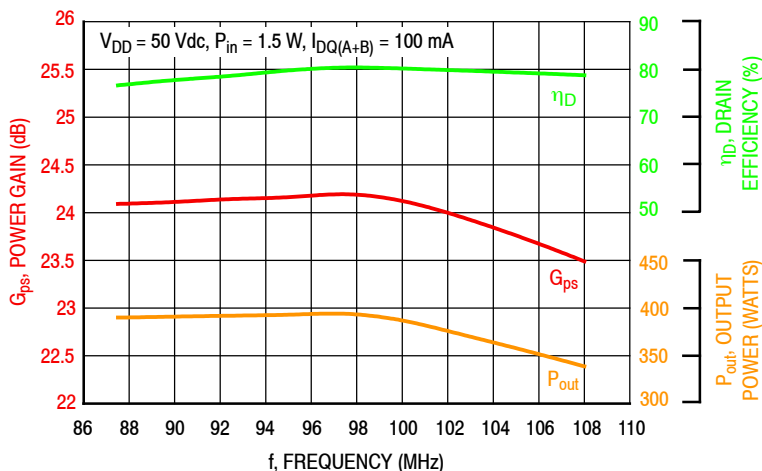


Figure 15. Power Gain, Drain Efficiency and CW Output Power versus Frequency at a Constant Input Power

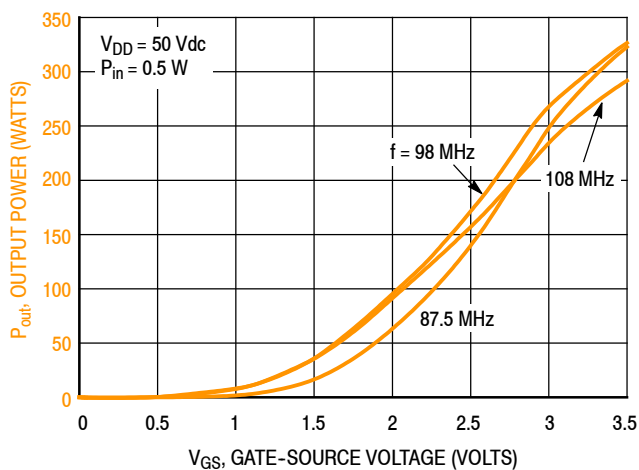


Figure 16. CW Output Power versus Gate-Source Voltage at a Constant Input Power

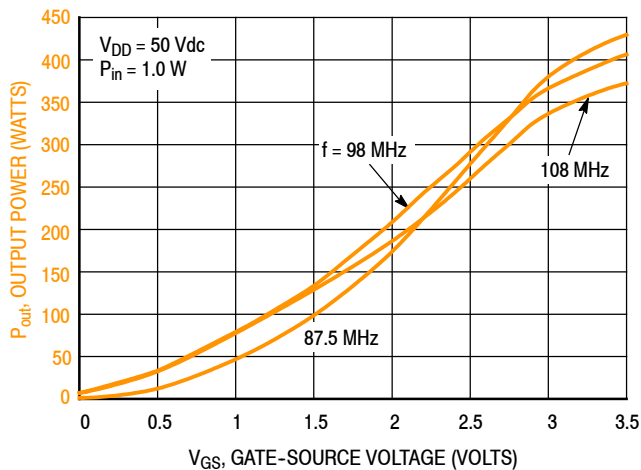
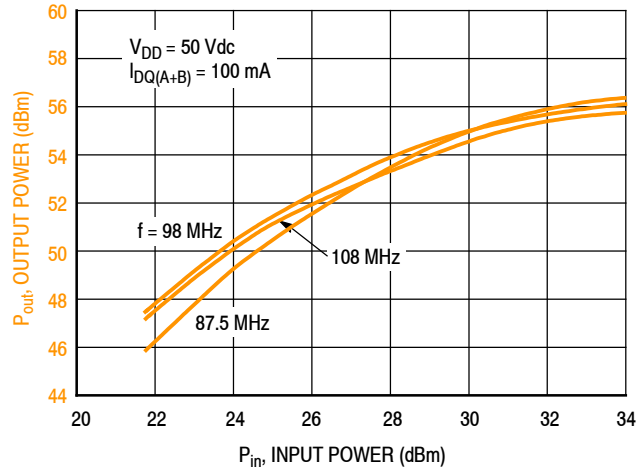


Figure 17. CW Output Power versus Gate-Source Voltage at a Constant Input Power

TYPICAL CHARACTERISTICS — 87.5–108 MHz BROADBAND REFERENCE CIRCUIT



| f (MHz) | P1dB (W) | P3dB (W) |
|---------|----------|----------|
| 87.5 | 346 | 429 |
| 98 | 293 | 379 |
| 108 | 240 | 355 |

Figure 18. CW Output Power versus Input Power

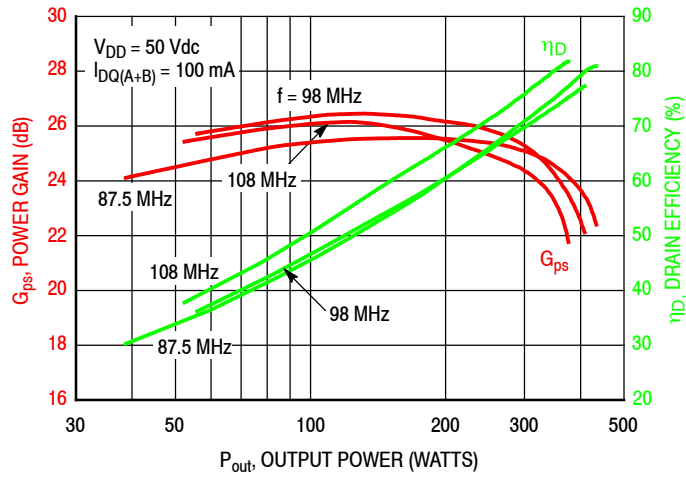
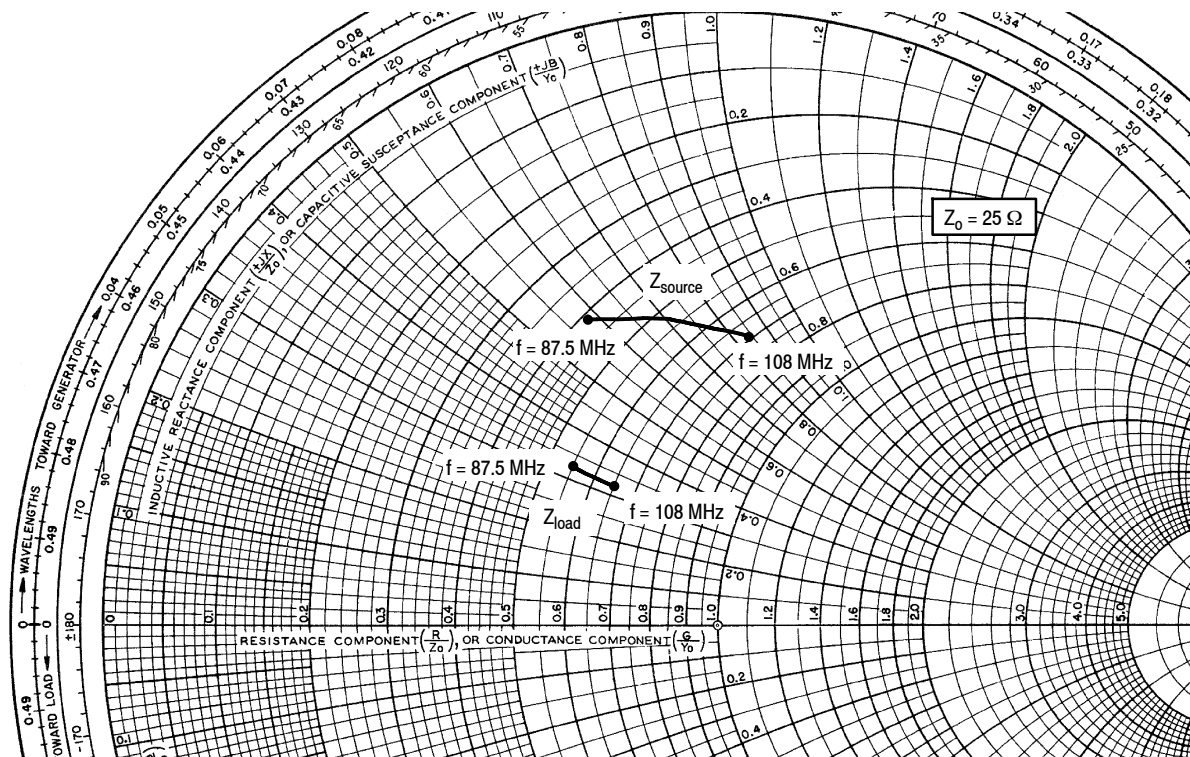


Figure 19. Power Gain and Drain Efficiency versus CW Output Power

87.5–108 MHz BROADBAND REFERENCE CIRCUIT



$V_{DD} = 50 \text{ Vdc}$, $I_{DQ(A+B)} = 100 \text{ mA}$, $P_{out} = 300 \text{ W CW}$

| f MHz | Z_{source} Ω | Z_{load} Ω |
|----------|--------------------------|------------------------|
| 87.5 | $10.3 + j14.4$ | $13.7 + j8.15$ |
| 92 | $11.5 + j15.8$ | $14.2 + j8.09$ |
| 96 | $12.6 + j17.0$ | $14.7 + j8.04$ |
| 100 | $13.9 + j18.2$ | $15.2 + j7.99$ |
| 104 | $15.5 + j19.6$ | $15.7 + j7.94$ |
| 108 | $17.2 + j20.9$ | $16.2 + j7.89$ |

Z_{source} = Test circuit impedance as measured from gate to gate, balanced configuration.

Z_{load} = Test circuit impedance as measured from drain to drain, balanced configuration.

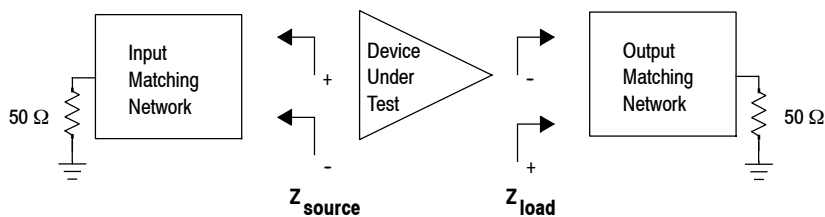


Figure 20. Broadband Series Equivalent Source and Load Impedance — 87.5–108 MHz

HARMONIC MEASUREMENTS — 87.5–108 MHz BROADBAND REFERENCE CIRCUIT

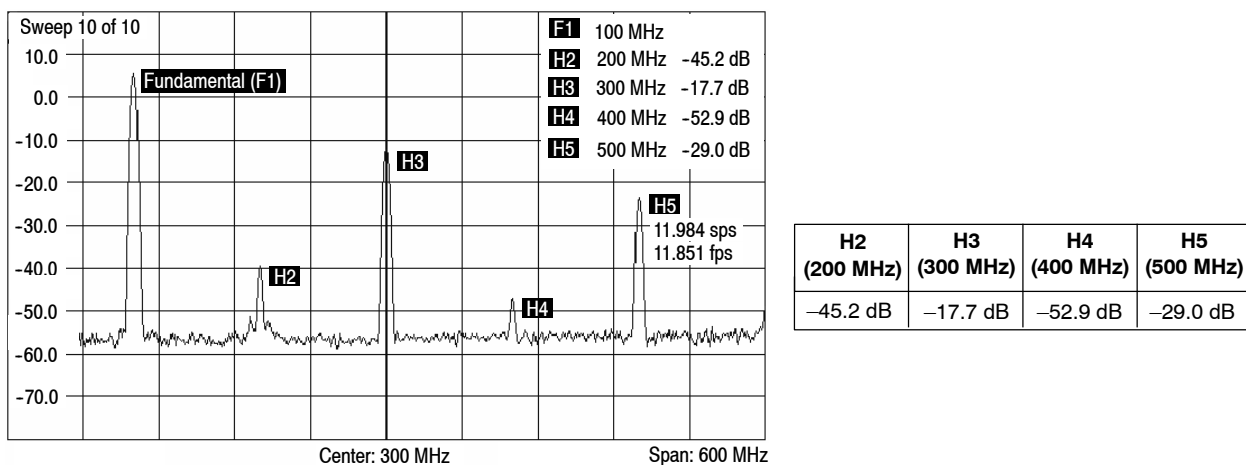
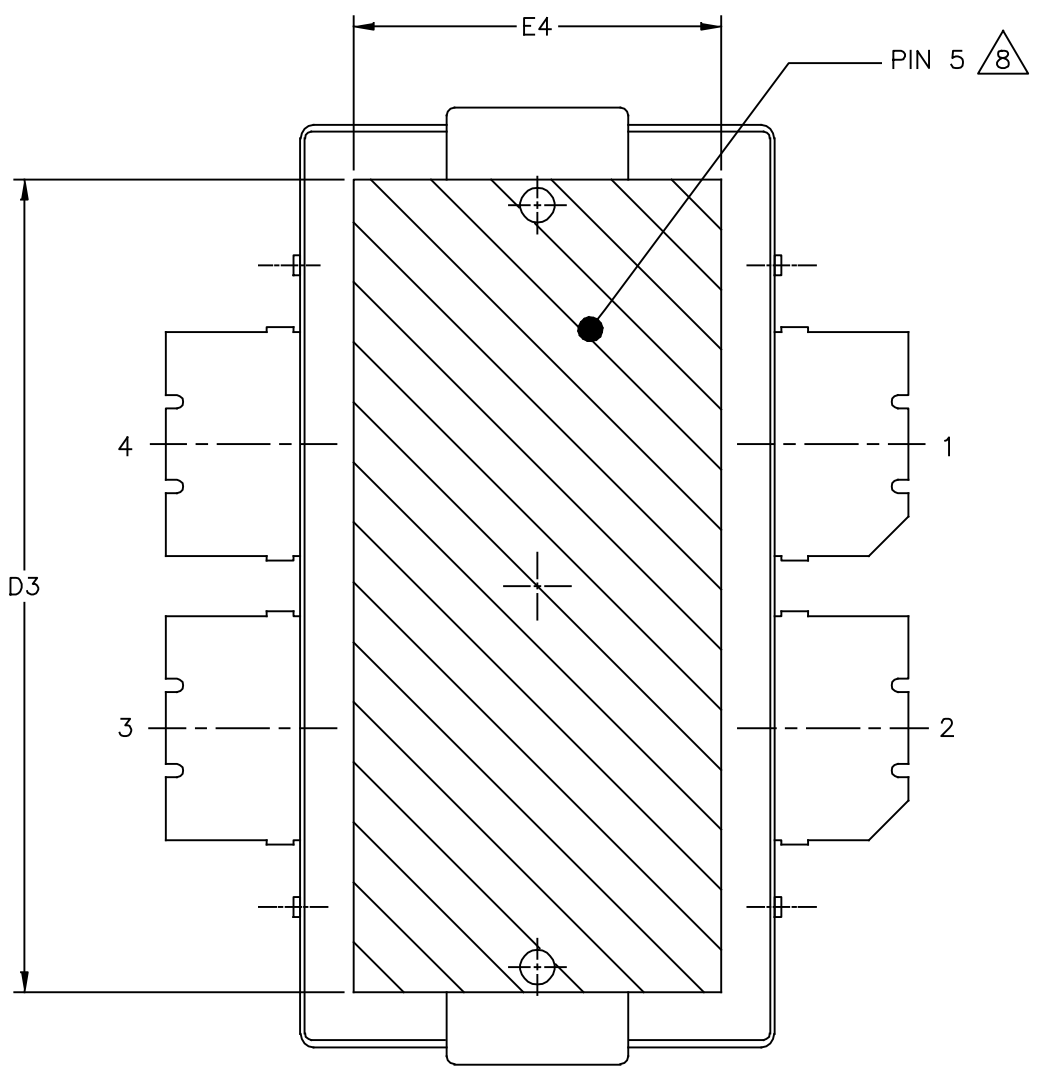


Figure 21. 100 MHz Harmonics @ 300 W CW



VIEW Y-Y

| | | |
|---|--------------------------------------|----------------------------|
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| TITLE: TO-270WB-4 | DOCUMENT NO: 98ASA10577D REV: E | |
| | STANDARD: NON-JEDEC | |
| | 27 AUG 2013 | |

NOTES:

1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE H IS LOCATED AT THE TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 INCH (0.15MM) PER SIDE. DIMENSIONS D1 AND E1 DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE H.
5. DIMENSIONS b1 DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 INCH (0.13MM) TOTAL IN EXCESS OF THE b1 DIMENSION AT MAXIMUM MATERIAL CONDITION.
6. DATUMS A AND B TO BE DETERMINED AT DATUM PLANE H.
7. DIMENSION A2 APPLIES WITHIN ZONE J ONLY.
8. HATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SLUG. DIMENSIONS D3 AND D4 REPRESENT THE VALUES BETWEEN THE TWO OPPOSITE POINTS ALONG THE EDGES OF EXPOSED AREA OF HEAT SLUG.
9. DIMPLED HOLE REPRESENTS INPUT SIDE.
10. THESE SURFACES OF THE HEAT SLUG ARE NOT PART OF THE SOLDERABLE SURFACES AND MAY REMAIN UNPLATED.

| DIM | INCH | | MILLIMETER | | DIM | INCH | | MILLIMETER | |
|---|------|------|--------------------|-------|--------------------------------------|----------------------------|------|----------------|------|
| | MIN | MAX | MIN | MAX | | MIN | MAX | MIN | MAX |
| AA | .100 | .104 | 2.54 | 2.64 | F | .025 BSC | | 0.64 BSC | |
| A1 | .039 | .043 | 0.99 | 1.09 | b1 | .164 | .170 | 4.17 | 4.32 |
| A2 | .040 | .042 | 1.02 | 1.07 | c1 | .007 | .011 | 0.18 | 0.28 |
| D | .712 | .720 | 18.08 | 18.29 | e | .106 BSC | | 2.69 BSC | |
| D1 | .688 | .692 | 17.48 | 17.58 | e1 | .239 INFO ONLY | | 6.07 INFO ONLY | |
| D2 | .011 | .019 | 0.28 | 0.48 | aaa | .004 | | 0.10 | |
| D3 | .600 | --- | 15.24 | --- | bbb | .008 | | 0.20 | |
| E | .551 | .559 | 14.00 | 14.20 | | | | | |
| E1 | .353 | .357 | 8.97 | 9.07 | | | | | |
| E2 | .132 | .140 | 3.35 | 3.56 | | | | | |
| E3 | .124 | .132 | 3.15 | 3.35 | | | | | |
| E4 | .270 | --- | 6.86 | --- | | | | | |
| E5 | .346 | .350 | 8.79 | 8.89 | | | | | |
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| | | | | | STANDARD: NON-JEDEC | | | | |
| | | | | | 27 AUG 2013 | | | | |

PRODUCT DOCUMENTATION AND SOFTWARE

Refer to the following resources to aid your design process.

Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers
- AN1643: RF LDMOS Power Modules for GSM Base Station Application: Optimum Biasing Circuit

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

Software

- Electromigration MTTF Calculator

For Software, do a Part Number search at <http://www.freescale.com>, and select the "Part Number" link. Go to the Software & Tools tab on the part's Product Summary page to download the respective tool.

REVISION HISTORY

The following table summarizes revisions to this document.

| Revision | Date | Description |
|----------|-----------|---|
| 0 | July 2014 | <ul style="list-style-type: none"> • Initial Release of Data Sheet |

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- Техническая поддержка проекта;
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